DATA SHEET

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GOLDSCOPE SD°510GOLDSCOPE SD°515GOLDSCOPE SD°520GOLDSCOPE SD°550

X-Ray Fluorescence Measuring Instruments Optimized for Fast, Cost-effective and Non-destructive Analysis of Jewellery, Coins and Precious Metals



🔲 Coating Thickness 🛄 Material Analysis 🖾 Nanoindentation 🔍 Material Testing

GOLDSCOPE SD®

Description

The X-ray fluorescence measuring instruments of the GOLDSCOPE SD[®] series are optimized for fast, cost-effective and non-destructive analysis of jewellery, coins and precious metals. Furthermore, the instruments are well suited for determining the thickness of gold coatings on sterling silver and rhodium coatings on gold alloys.

The GOLDSCOPE SD[®] series comprises four different instruments to fulfill the specific demands from the fast purchase and sale of gold up to the high-precision analysis of precious metals.

Typical fields of application are the analysis of:

- Jewellery, precious metals and dental alloys
- Yellow and white gold
- Platinum and silver
- Rhodium
- Alloys and coatings

Outstanding accuracy and long-term stability are characteristics of all X-RAY systems from **FISCHER**. The necessity of recalibration is considerably reduced, saving time and effort.

The GOLDSCOPE SD[®] 510 and SD[®] 515 instruments are equipped with a modern silicon PIN detector, which achieves high accuracy and good detection sensitivity. For even higher resolution, the GOLDSCOPE SD[®] 520 and SD 550 instruments with their Silicon Drift Detectors (SDD) are available.

The fundamental parameter method by **FISCHER** allows for the analysis without calibration.

Design

The GOLDSCOPE SD[®] instruments are designed as user-friendly bench-top instruments. Due to their compact design, the instruments are lightweight and require only little space.

The GOLDSCOPE SD[®] 510 offers the smallest footprint, because the measurement chamber door does not open upwards, but towards the front. Thus, you can place a notebook for operation onto the instrument, which saves space.

For quick and easy sample positioning, the X-ray source and detector assembly is located in the instrument's lower chamber. The measuring direction is from underneath the sample, which is supported by a transparent window.

The integrated video-microscope with zoom and crosshairs simplifies sample placement and allows for a precise measuring spot adjustment.

The entire operation and evaluation of measurements as well as the clear presentation of measurement data is performed on a PC, using the powerful and user-friendly Win FTM® software

All GOLDSCOPE SD[®] instruments fulfill DIN ISO 3497 and ASTM B 568.

| Application | GOLDSCOPE SD [®] 510 | GOLDSCOPE SD [®] 515 | GOLDSCOPE SD [®] 520 | GOLDSCOPE SD [®] 550 |
|---------------------------------|-------------------------------|---|-------------------------------|---|
| Recommended area of application | Retail shops | High end retail show- rooms, small assaying offices | | Hallmarking centers, jewellery manufac- turing, assaying offices |

| General Specification | | | | |
|---------------------------------|---|---|--|--|
| Intended use | Energy dispersive X-ray measuring instrument (EDXRF) to analyze precious metals | | | |
| Design | GOLDSCOPE SD® 510: Bench top unit with towards the front opening hood, GOLDSCOPE SD® 515, 520, 550: Bench top unit with upwards opening hood | | | |
| Measuring direction | Bottom up | | | |
| Electrical Data | | | | |
| Power supply and consumption | AC 115 or 230 V, 50/60 Hz, max. 120 W without evaluation PC | | | |
| Protection class | Ip40 | | | |
| Environmental Conditions | | | | |
| Operating temperature | 10 °C – 45 °C / 50 °F – 113 °F | | | |
| Storage/Transport temperature | 0 °C – 50 °C / 32 °F – 122 °F | | | |
| Relative humidity | ≤ 95 % | | | |
| Sample Alignment | | | | |
| Sample positioning | Manually | | | |
| Video microscope | High-resolution CCD colour camera for optical monitoring of the measurement locationalong the primary beam axis, Crosshairs with a calibrated scale (ruler) and spot-indicator, Adjustable LED illumination | | | |
| Zoom factor | Digital 1x, 2x, 3x, 4x | | | |
| Evaluation Unit | | | | |
| Computer | Windows [®] -PC | | | |
| Software | WinFTM®- optimized for GOLDSCOPE SD®, including Gold Setup GOLDSCOPE with measuring applications for gold and jewellery | | | |
| Standards | GOLDSCOPE SD [®] 510 | GOLDSCOPE SD®515 GOLDSCOPE SD®520 GOLDSCOPE SD®550 | | |
| CE approval | | EN 61010, EN 61326 | | |
| X-Ray standards | DIN ISO 3497 and ASTM B 568 | | | |
| Approval | Individual accep- tance inspection as a fully protected instrument accor- ding to the German regulations "Deutsche Röntgen- verordnung-RöV". | Fully protected instrument with type approval according to the German regulations "Deutsche Röntgen- verordnung - RöV". | | |
| Sample Stage | | | | |
| Design | Fixed sample support | | | |
| Max. sample weight [kg/lb] | 13/29 | | | |
| Usable sample placement area | 305 x 490/ | 310 x 320/ | | |
| [mm/in] | 12 x 19.3 | 12.2 x 12.6 | | |
| Max. sample height [mm/in] | 130/5.1 | 90/3.5 | | |

| Dimensions | GOLDSCOPE SD [®] 510 | GOLDSCOPE SD [®] 515 | GOLDSCOPE SD [®] 520 | GOLDSCOPE SD [®] 550 | |
|---|--|---|---|---|--|
| External dimensions | 405 x 588 x 426/ 403 x 1 | | 588 x 365/16 x 23.2 x 14.4 | | |
| Width x depth x height [mm/in] | 16 x 23 x 17 | | | | |
| Weight [kg/lb] | approx. 45/99 | арргох. 45/99 | | | |
| X-Ray Source | | | | | |
| X-ray tube | Tungsten tube, th | ermally stabilized | Micro-focus tungsten tube with beryllium window | | |
| High voltage, three steps [kV] | 30, 40, 50 | 30, 40, 50 | 30, 40, 50 | 10, 30, 50 | |
| Primary filter, Material and thickness [µm/mils] | none | none | fixed Al 500/19.7 | 6x changeable: Ni 10/0.4 no filter Al 1000/39.4 Al 500/19.7 Al 100/3.9 Mylar [®] 100/3.9 | |
| Aperture (Collimator) | Fixed | Fixed | Fixed, | 4x changeable: | |
| Ø [mm/mils] | Standard 1,0/39 Option 0.6/24; | Standard 1,0/39 Option 0.6/24; 1.0/39 or 2.0/79 | Standard 1.0/39 Option 0.6/24; 1.0/39 or 2.0/79 | 0.2/8; 0.6/24; 1.0/39; 2.0/79 | |
| Smallest measurement spot* Ø [mm/mils] | approx. 0.7/28* | approx. 0.7/28* | approx. 0.7/28* | approx. 0.3 /12* | |
| | * depends on the measuring distance and on the aperture, the actual measurement spot size is shown in the video image | | | | |
| X-Ray Detection | | | | | |
| Detector type | Silicon PIN detector | peltier-cooled | Silicon Drift Detector (SDD), peltier-cooled | | |
| Resolution fwhm for Mn-K _a [eV] | ≤] | 80 | ≤ 160 | | |
| Element range | S (16) to U (92) Al (13) to U (92) | | | Al (13) to U (92) | |
| Measuring distance [mm/in] | 0 – 25/0 – 1, Distance compensation with patented DCM method for simplified measurements at varying distances. For particular applications or for higher demands on accuracy an additional calibration might be necessary. | | | | |
| Repeatability for gold, | ≤ 1 ‰ | ≤ 1 ‰ | ≤0,5 ‰ | ≤0,5 ‰ | |
| measurement time 60 sec | with aperture | with aperture | with aperture | with aperture | |
| Ordor | 1.0 mm | 1.0 mm | 1.0 mm | 1.0 mm | |
| Order Order number | IN605-684 | IN605-685 | IN605-686 | IN605-687 | |
| | Incl. Gold Setup GOLDSCOPE with factory-calibrated measuring applications for gold and jewellery | | | | |
| | Special GOLDSCOPE SD® product modification and technical consultation on request | | | | |

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